Intel - EP20K100QC240-1 Datasheet





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The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

Details

Product Status	Obsolete
Number of LABs/CLBs	416
Number of Logic Elements/Cells	4160
Total RAM Bits	53248
Number of I/O	189
Number of Gates	263000
Voltage - Supply	2.375V ~ 2.625V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 85°C (TJ)
Package / Case	240-BFQFP
Supplier Device Package	240-PQFP (32x32)
Purchase URL	https://www.e-xfl.com/product-detail/intel/ep20k100qc240-1

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Each LE has two outputs that drive the local, MegaLAB, or FastTrack Interconnect routing structure. Each output can be driven independently by the LUT's or register's output. For example, the LUT can drive one output while the register drives the other output. This feature, called register packing, improves device utilization because the register and the LUT can be used for unrelated functions. The LE can also drive out registered and unregistered versions of the LUT output.

The APEX 20K architecture provides two types of dedicated high-speed data paths that connect adjacent LEs without using local interconnect paths: carry chains and cascade chains. A carry chain supports high-speed arithmetic functions such as counters and adders, while a cascade chain implements wide-input functions such as equality comparators with minimum delay. Carry and cascade chains connect LEs 1 through 10 in an LAB and all LABs in the same MegaLAB structure.

Carry Chain

The carry chain provides a very fast carry-forward function between LEs. The carry-in signal from a lower-order bit drives forward into the higherorder bit via the carry chain, and feeds into both the LUT and the next portion of the carry chain. This feature allows the APEX 20K architecture to implement high-speed counters, adders, and comparators of arbitrary width. Carry chain logic can be created automatically by the Quartus II software Compiler during design processing, or manually by the designer during design entry. Parameterized functions such as library of parameterized modules (LPM) and DesignWare functions automatically take advantage of carry chains for the appropriate functions.

The Quartus II software Compiler creates carry chains longer than ten LEs by linking LABs together automatically. For enhanced fitting, a long carry chain skips alternate LABs in a MegaLAB[™] structure. A carry chain longer than one LAB skips either from an even-numbered LAB to the next even-numbered LAB, or from an odd-numbered LAB to the next odd-numbered LAB. For example, the last LE of the first LAB in the upper-left MegaLAB structure carries to the first LE of the third LAB in the MegaLAB structure.

Figure 6 shows how an *n*-bit full adder can be implemented in n + 1 LEs with the carry chain. One portion of the LUT generates the sum of two bits using the input signals and the carry-in signal; the sum is routed to the output of the LE. The register can be bypassed for simple adders or used for accumulator functions. Another portion of the LUT and the carry chain logic generates the carry-out signal, which is routed directly to the carry-in signal of the next-higher-order bit. The final carry-out signal is routed to an LE, where it is driven onto the local, MegaLAB, or FastTrack Interconnect routing structures.

LE Operating Modes

The APEX 20K LE can operate in one of the following three modes:

- Normal mode
- Arithmetic mode
- Counter mode

Each mode uses LE resources differently. In each mode, seven available inputs to the LE—the four data inputs from the LAB local interconnect, the feedback from the programmable register, and the carry-in and cascade-in from the previous LE—are directed to different destinations to implement the desired logic function. LAB-wide signals provide clock, asynchronous clear, asynchronous preset, asynchronous load, synchronous clear, synchronous load, and clock enable control for the register. These LAB-wide signals are available in all LE modes.

The Quartus II software, in conjunction with parameterized functions such as LPM and DesignWare functions, automatically chooses the appropriate mode for common functions such as counters, adders, and multipliers. If required, the designer can also create special-purpose functions that specify which LE operating mode to use for optimal performance. Figure 8 shows the LE operating modes. Figure 11 shows the intersection of a row and column interconnect, and how these forms of interconnects and LEs drive each other.



Figure 11. Driving the FastTrack Interconnect

APEX 20KE devices include an enhanced interconnect structure for faster routing of input signals with high fan-out. Column I/O pins can drive the FastRow[™] interconnect, which routes signals directly into the local interconnect without having to drive through the MegaLAB interconnect. FastRow lines traverse two MegaLAB structures. Also, these pins can drive the local interconnect directly for fast setup times. On EP20K300E and larger devices, the FastRow interconnect drives the two MegaLABs in the top left corner, the two MegaLABs in the top right corner, the two MegaLABS in the bottom left corner, and the two MegaLABs in the bottom right corner. On EP20K200E and smaller devices, FastRow interconnect drives the two MegaLABs on the top and the two MegaLABs on the bottom of the device. On all devices, the FastRow interconnect drives all local interconnect in the appropriate MegaLABs except the local interconnect on the side of the MegaLAB opposite the ESB. Pins using the FastRow interconnect achieve a faster set-up time, as the signal does not need to use a MegaLAB interconnect line to reach the destination LE. Figure 12 shows the FastRow interconnect.



Figure 18. Deep Memory Block Implemented with Multiple ESBs

The ESB implements two forms of dual-port memory: read/write clock mode and input/output clock mode. The ESB can also be used for bidirectional, dual-port memory applications in which two ports read or write simultaneously. To implement this type of dual-port memory, two or four ESBs are used to support two simultaneous reads or writes. This functionality is shown in Figure 19.



Read/Write Clock Mode

The read/write clock mode contains two clocks. One clock controls all registers associated with writing: data input, WE, and write address. The other clock controls all registers associated with reading: read enable (RE), read address, and data output. The ESB also supports clock enable and asynchronous clear signals; these signals also control the read and write registers independently. Read/write clock mode is commonly used for applications where reads and writes occur at different system frequencies. Figure 20 shows the ESB in read/write clock mode.



Notes to Figure 20:

- (1) All registers can be cleared asynchronously by ESB local interconnect signals, global signals, or the chip-wide reset.
- (2) APEX 20KE devices have four dedicated clocks.



Figure 25. APEX 20K Bidirectional I/O Registers Note (1)



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APEX 20KE devices also support the MultiVolt I/O interface feature. The APEX 20KE VCCINT pins must always be connected to a 1.8-V power supply. With a 1.8-V V_{CCINT} level, input pins are 1.8-V, 2.5-V, and 3.3-V tolerant. The VCCIO pins can be connected to either a 1.8-V, 2.5-V, or 3.3-V power supply, depending on the I/O standard requirements. When the VCCIO pins are connected to a 1.8-V power supply, the output levels are compatible with 1.8-V systems. When VCCIO pins are connected to a 2.5-V power supply, the output levels are compatible with 2.5-V systems. When VCCIO pins are connected to a 3.3-V power supply, the output levels are sometime with 2.5-V systems. When VCCIO pins are connected to a 3.3-V power supply, the output high is 3.3 V and compatible with 3.3-V or 5.0-V systems. An APEX 20KE device is 5.0-V tolerant with the addition of a resistor.

Table 13 summarizes APEX 20KE MultiVolt I/O support.

Table 13. APEX 20KE MultiVolt I/O Support Note (1)								
V _{CCIO} (V)	(V) Input Signals (V) Output Signals (V)							
	1.8	2.5	3.3	5.0	1.8	2.5	3.3	5.0
1.8	\checkmark	\checkmark	\checkmark		\checkmark			
2.5	\checkmark	\checkmark	>			\checkmark		
3.3	\checkmark	\checkmark	\checkmark	(2)			✓(3)	

Notes to Table 13:

 The PCI clamping diode must be disabled to drive an input with voltages higher than V_{CCIO}, except for the 5.0-V input case.

(2) An APEX 20KE device can be made 5.0-V tolerant with the addition of an external resistor. You also need a PCI clamp and series resistor.

(3) When V_{CCIO} = 3.3 V, an APEX 20KE device can drive a 2.5-V device with 3.3-V tolerant inputs.

ClockLock & ClockBoost Features

APEX 20K devices support the ClockLock and ClockBoost clock management features, which are implemented with PLLs. The ClockLock circuitry uses a synchronizing PLL that reduces the clock delay and skew within a device. This reduction minimizes clock-to-output and setup times while maintaining zero hold times. The ClockBoost circuitry, which provides a clock multiplier, allows the designer to enhance device area efficiency by sharing resources within the device. The ClockBoost circuitry allows the designer to distribute a low-speed clock and multiply that clock on-device. APEX 20K devices include a high-speed clock tree; unlike ASICs, the user does not have to design and optimize the clock tree. The ClockLock and ClockBoost features work in conjunction with the APEX 20K device's high-speed clock to provide significant improvements in system performance and band-width. Devices with an X-suffix on the ordering code include the ClockLock circuit.

The ClockLock and ClockBoost features in APEX 20K devices are enabled through the Quartus II software. External devices are not required to use these features.

For designs that require both a multiplied and non-multiplied clock, the clock trace on the board can be connected to CLK2p. Table 14 shows the combinations supported by the ClockLock and ClockBoost circuitry. The CLK2p pin can feed both the ClockLock and ClockBoost circuitry in the APEX 20K device. However, when both circuits are used, the other clock pin (CLK1p) cannot be used.

Table 14. Multiplication Factor Combinations				
Clock 1	Clock 2			
×1	×1			
×1, ×2 ×2				
×1, ×2, ×4 ×4				

APEX 20KE ClockLock Feature

APEX 20KE devices include an enhanced ClockLock feature set. These devices include up to four PLLs, which can be used independently. Two PLLs are designed for either general-purpose use or LVDS use (on devices that support LVDS I/O pins). The remaining two PLLs are designed for general-purpose use. The EP20K200E and smaller devices have two PLLs; the EP20K300E and larger devices have four PLLs.

The following sections describe some of the features offered by the APEX 20KE PLLs.

External PLL Feedback

The ClockLock circuit's output can be driven off-chip to clock other devices in the system; further, the feedback loop of the PLL can be routed off-chip. This feature allows the designer to exercise fine control over the I/O interface between the APEX 20KE device and another high-speed device, such as SDRAM.

Clock Multiplication

The APEX 20KE ClockBoost circuit can multiply or divide clocks by a programmable number. The clock can be multiplied by $m/(n \times k)$ or $m/(n \times v)$, where *m* and *k* range from 2 to 160, and *n* and *v* range from 1 to 16. Clock multiplication and division can be used for time-domain multiplexing and other functions, which can reduce design LE requirements.



Figure 32. APEX 20K AC Test Conditions Note (1)

Note to Figure 32:

Power supply transients can affect AC measurements. Simultaneous transitions of (1) multiple outputs should be avoided for accurate measurement. Threshold tests must not be performed under AC conditions. Large-amplitude, fast-groundcurrent transients normally occur as the device outputs discharge the load capacitances. When these transients flow through the parasitic inductance between the device ground pin and the test system ground, significant reductions in observable noise immunity can result.

Operating **Conditions**

Tables 23 through 26 provide information on absolute maximum ratings, recommended operating conditions, DC operating conditions, and capacitance for 2.5-V APEX 20K devices.

	Table 25. AT EX 20K 5.0-V Toletani Device Absolute maximum frainigs (1), (2)					
Symbol	Parameter	Conditions	Min	Max	Unit	
V _{CCINT}	Supply voltage	With respect to ground (3)	-0.5	3.6	V	
V _{CCIO}			-0.5	4.6	V	
VI	DC input voltage		-2.0	5.75	V	
I _{OUT}	DC output current, per pin		-25	25	mA	
T _{STG}	Storage temperature	No bias	-65	150	°C	
T _{AMB}	Ambient temperature	Under bias	-65	135	°C	
Τ _J	Junction temperature	PQFP, RQFP, TQFP, and BGA packages, under bias		135	°C	
		Ceramic PGA packages, under bias		150	°C	

Table 23. APEX 20K 5.0-V Tolerant Device Absolute Maximum Ratings	Notes (1), (2)
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Table 25. APEX 20K 5.0-V Tolerant Device DC Operating Conditions (Part 2 of 2) Notes (2), (7), (8)							
Symbol	Parameter	Conditions	Min	Тур	Max	Unit	
V _{OL}	3.3-V low-level TTL output voltage	I _{OL} = 12 mA DC, V _{CCIO} = 3.00 V (11)			0.45	V	
	3.3-V low-level CMOS output voltage	$I_{OL} = 0.1 \text{ mA DC},$ $V_{CCIO} = 3.00 \text{ V} (11)$			0.2	V	
	3.3-V low-level PCI output voltage	I _{OL} = 1.5 mA DC, V _{CCIO} = 3.00 to 3.60 V (11)			$0.1 imes V_{CCIO}$	V	
	2.5-V low-level output voltage	I _{OL} = 0.1 mA DC, V _{CCIO} = 2.30 V (11)			0.2	V	
		I _{OL} = 1 mA DC, V _{CCIO} = 2.30 V (11)			0.4	V	
		I _{OL} = 2 mA DC, V _{CCIO} = 2.30 V (11)			0.7	V	
I _I	Input pin leakage current	$V_1 = 5.75$ to -0.5 V	-10		10	μA	
I _{OZ}	Tri-stated I/O pin leakage current	$V_{O} = 5.75$ to -0.5 V	-10		10	μA	
I _{CC0}	V _{CC} supply current (standby) (All ESBs in power-down mode)	V_1 = ground, no load, no toggling inputs, -1 speed grade (12)		10		mA	
		V ₁ = ground, no load, no toggling inputs, -2, -3 speed grades (12)		5		mA	
R _{CONF}	Value of I/O pin pull-up resistor	V _{CCIO} = 3.0 V (13)	20		50	W	
	before and during configuration	V _{CCIO} = 2.375 V (13)	30		80	W	

Table 29. APEX 20KE Device DC Operating Conditions Notes (7), (8), (9)							
Symbol	Parameter	Conditions	Min	Тур	Max	Unit	
V _{IH}	High-level LVTTL, CMOS, or 3.3-V PCI input voltage		1.7, 0.5 × V _{CCIO} (10)		4.1	V	
V _{IL}	Low-level LVTTL, CMOS, or 3.3-V PCI input voltage		-0.5		0.8, 0.3 × V _{CCIO} (10)	V	
V _{OH}	3.3-V high-level LVTTL output voltage	I _{OH} = -12 mA DC, V _{CCIO} = 3.00 V (11)	2.4			V	
	3.3-V high-level LVCMOS output voltage	I _{OH} = -0.1 mA DC, V _{CCIO} = 3.00 V (11)	V _{CCIO} – 0.2			V	
	3.3-V high-level PCI output voltage	I _{OH} = -0.5 mA DC, V _{CCIO} = 3.00 to 3.60 V (11)	$0.9 imes V_{CCIO}$			V	
	2.5-V high-level output voltage	I _{OH} = -0.1 mA DC, V _{CCIO} = 2.30 V (11)	2.1			V	
		I _{OH} = -1 mA DC, V _{CCIO} = 2.30 V (11)	2.0			V	
		I _{OH} = -2 mA DC, V _{CCIO} = 2.30 V (11)	1.7			V	
V _{OL}	3.3-V low-level LVTTL output voltage	I _{OL} = 12 mA DC, V _{CCIO} = 3.00 V <i>(12)</i>			0.4	V	
	3.3-V low-level LVCMOS output voltage	I _{OL} = 0.1 mA DC, V _{CCIO} = 3.00 V (<i>12</i>)			0.2	V	
	3.3-V low-level PCI output voltage	$I_{OL} = 1.5 \text{ mA DC},$ $V_{CCIO} = 3.00 \text{ to } 3.60 \text{ V}$ (12)			0.1 × V _{CCIO}	V	
	2.5-V low-level output voltage	I _{OL} = 0.1 mA DC, V _{CCIO} = 2.30 V (<i>12</i>)			0.2	V	
		I _{OL} = 1 mA DC, V _{CCIO} = 2.30 V <i>(12)</i>			0.4	V	
		I _{OL} = 2 mA DC, V _{CCIO} = 2.30 V <i>(12)</i>			0.7	V	
I _I	Input pin leakage current	V ₁ = 4.1 to -0.5 V (13)	-10		10	μΑ	
I _{OZ}	Tri-stated I/O pin leakage current	V _O = 4.1 to -0.5 V (13)	-10		10	μA	
I _{CC0}	V _{CC} supply current (standby) (All ESBs in power-down mode)	V _I = ground, no load, no toggling inputs, -1 speed grade		10		mA	
		V ₁ = ground, no load, no toggling inputs, -2, -3 speed grades		5		mA	
R _{CONF}	Value of I/O pin pull-up resistor	V _{CCIO} = 3.0 V (14)	20		50	kΩ	
	before and during configuration	V _{CCIO} = 2.375 V (14)	30		80	kΩ	
		V _{CCIO} = 1.71 V (14)	60		150	kΩ	

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For DC Operating Specifications on APEX 20KE I/O standards, please refer to *Application Note 117 (Using Selectable I/O Standards in Altera Devices).*

Table 30. APEX 20KE Device Capacitance Note (15)						
Symbol	Parameter	Conditions	Min	Max	Unit	
C _{IN}	Input capacitance	V _{IN} = 0 V, f = 1.0 MHz		8	pF	
CINCLK	Input capacitance on dedicated clock pin	V _{IN} = 0 V, f = 1.0 MHz		12	pF	
C _{OUT}	Output capacitance	V _{OUT} = 0 V, f = 1.0 MHz		8	pF	

Notes to Tables 27 through 30:

- (1) See the Operating Requirements for Altera Devices Data Sheet.
- (2) Minimum DC input is -0.5 V. During transitions, the inputs may undershoot to -2.0 V or overshoot to 5.75 V for input currents less than 100 mA and periods shorter than 20 ns.
- (3) Numbers in parentheses are for industrial-temperature-range devices.
- (4) Maximum V_{CC} rise time is 100 ms, and V_{CC} must rise monotonically.
- (5) Minimum DC input is -0.5 V. During transitions, the inputs may undershoot to -2.0 V or overshoot to the voltage shown in the following table based on input duty cycle for input currents less than 100 mA. The overshoot is dependent upon duty cycle of the signal. The DC case is equivalent to 100% duty cycle.

Vin	Max. Duty Cycle
4.0V	100% (DC)
4.1	90%

- 4.2 50%
- 4.3 30%
- 4.4 17%
- 4.5 10%
- (6) All pins, including dedicated inputs, clock, I/O, and JTAG pins, may be driven before V_{CCINT} and V_{CCIO} are powered.
- (7) Typical values are for $T_A = 25^\circ$ C, $V_{CCINT} = 1.8$ V, and $V_{CCIO} = 1.8$ V, 2.5 V or 3.3 V.
- (8) These values are specified under the APEX 20KE device recommended operating conditions, shown in Table 24 on page 60.
- (9) Refer to Application Note 117 (Using Selectable I/O Standards in Altera Devices) for the V_{IH}, V_{IL}, V_{OH}, V_{OL}, and I_I parameters when VCCIO = 1.8 V.
- (10) The APEX 20KE input buffers are compatible with 1.8-V, 2.5-V and 3.3-V (LVTTL and LVCMOS) signals. Additionally, the input buffers are 3.3-V PCI compliant. Input buffers also meet specifications for GTL+, CTT, AGP, SSTL-2, SSTL-3, and HSTL.
- (11) The I_{OH} parameter refers to high-level TTL, PCI, or CMOS output current.
- (12) The I_{OL} parameter refers to low-level TTL, PCI, or CMOS output current. This parameter applies to open-drain pins as well as output pins.
- (13) This value is specified for normal device operation. The value may vary during power-up.
- (14) Pin pull-up resistance values will be lower if an external source drives the pin higher than V_{CCIO}.
- (15) Capacitance is sample-tested only.

Figure 33 shows the relationship between $\rm V_{CCIO}$ and $\rm V_{CCINT}$ for 3.3-V PCI compliance on APEX 20K devices.



Figure 34 shows the typical output drive characteristics of APEX 20K devices with 3.3-V and 2.5-V V_{CCIO}. The output driver is compatible with the 3.3-V *PCI Local Bus Specification, Revision 2.2* (when VCCIO pins are connected to 3.3 V). 5-V tolerant APEX 20K devices in the -1 speed grade are 5-V PCI compliant over all operating conditions.







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Table 31. APEX 20K f _{MAX} Timing Parameters (Part 2 of 2)				
Symbol	Parameter			
t _{ESBDATACO2}	ESB clock-to-output delay without output registers			
t _{ESBDD}	ESB data-in to data-out delay for RAM mode			
t _{PD}	ESB macrocell input to non-registered output			
t _{PTERMSU}	ESB macrocell register setup time before clock			
t _{PTERMCO}	ESB macrocell register clock-to-output delay			
t _{F1-4}	Fanout delay using local interconnect			
t _{F5-20}	Fanout delay using MegaLab Interconnect			
t _{F20+}	Fanout delay using FastTrack Interconnect			
t _{CH}	Minimum clock high time from clock pin			
t _{CL}	Minimum clock low time from clock pin			
t _{CLRP}	LE clear pulse width			
t _{PREP}	LE preset pulse width			
t _{ESBCH}	Clock high time			
t _{ESBCL}	Clock low time			
t _{ESBWP}	Write pulse width			
t _{ESBRP}	Read pulse width			

Tables 32 and 33 describe APEX 20K external timing parameters.

Table 32. APEX 20K External Timing Parameters Note (1)				
Symbol	Clock Parameter			
t _{INSU}	Setup time with global clock at IOE register			
t _{INH}	Hold time with global clock at IOE register			
t _{оитсо}	Clock-to-output delay with global clock at IOE register			

Table 33. APEX 20K External Bidirectional Timing Parameters Note (1)					
Symbol	Parameter	Conditions			
t _{INSUBIDIR}	Setup time for bidirectional pins with global clock at same-row or same- column LE register				
t _{INHBIDIR}	Hold time for bidirectional pins with global clock at same-row or same-column LE register				
^t OUTCOBIDIR	Clock-to-output delay for bidirectional pins with global clock at IOE register	C1 = 10 pF			
t _{XZBIDIR}	Synchronous IOE output buffer disable delay	C1 = 10 pF			
t _{ZXBIDIR}	Synchronous IOE output buffer enable delay, slow slew rate = off	C1 = 10 pF			

Table 46. EP20k	Table 46. EP20K200 External Bidirectional Timing Parameters											
Symbol	-1 Speed Grade		-2 Spe	-2 Speed Grade		-3 Speed Grade						
	Min	Max	Min	Max	Min	Max						
t _{INSUBIDIR} (1)	1.9		2.3		2.6		ns					
t _{INHBIDIR} (1)	0.0		0.0		0.0		ns					
t _{OUTCOBIDIR} (1)	2.0	4.6	2.0	5.6	2.0	6.8	ns					
t _{XZBIDIR} (1)		5.0		5.9		6.9	ns					
t _{ZXBIDIR} (1)		5.0		5.9		6.9	ns					
t _{INSUBIDIR} (2)	1.1		1.2		-		ns					
t _{INHBIDIR} (2)	0.0		0.0		-		ns					
t _{OUTCOBIDIR} (2)	0.5	2.7	0.5	3.1	-	-	ns					
t _{XZBIDIR} (2)		4.3		5.0		-	ns					
t _{ZXBIDIR} (2)		4.3		5.0		-	ns					

Table 47. EP20K400 External Timing Parameters

Symbol	ol -1 Speed Grade		-2 Spee	-2 Speed Grade		-3 Speed Grade		
	Min	Max	Min	Max	Min	Max		
t _{INSU} (1)	1.4		1.8		2.0		ns	
t _{INH} (1)	0.0		0.0		0.0		ns	
t _{OUTCO} (1)	2.0	4.9	2.0	6.1	2.0	7.0	ns	
t _{INSU} (2)	0.4		1.0		-		ns	
t _{INH} (2)	0.0		0.0		-		ns	
t _{OUTCO} (2)	0.5	3.1	0.5	4.1	-	-	ns	

Table 48. EP20K400 External Bidirectional Timing Parameters

Symbol	-1 Spee	d Grade	-2 Spee	d Grade	-3 Speed Grade		Unit
	Min	Max	Min	Max	Min	Max	
t _{INSUBIDIR} (1)	1.4		1.8		2.0		ns
t _{INHBIDIR} (1)	0.0		0.0		0.0		ns
t _{OUTCOBIDIR} (1)	2.0	4.9	2.0	6.1	2.0	7.0	ns
t _{XZBIDIR} (1)		7.3		8.9		10.3	ns
t _{ZXBIDIR} (1)		7.3		8.9		10.3	ns
t _{INSUBIDIR} (2)	0.5		1.0		-		ns
t _{INHBIDIR} (2)	0.0		0.0		-		ns
t _{OUTCOBIDIR} (2)	0.5	3.1	0.5	4.1	-	-	ns
t _{XZBIDIR} (2)		6.2		7.6		-	ns
t _{ZXBIDIR} (2)		6.2		7.6		_	ns

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Table 52. EP	Table 52. EP20K30E Minimum Pulse Width Timing Parameters											
Symbol	rmbol -1		-	-2		-3						
	Min	Max	Min	Мах	Min	Max						
t _{CH}	0.55		0.78		1.15		ns					
t _{CL}	0.55		0.78		1.15		ns					
t _{CLRP}	0.22		0.31		0.46		ns					
t _{PREP}	0.22		0.31		0.46		ns					
t _{ESBCH}	0.55		0.78		1.15		ns					
t _{ESBCL}	0.55		0.78		1.15		ns					
t _{ESBWP}	1.43		2.01		2.97		ns					
t _{ESBRP}	1.15		1.62		2.39		ns					

Table 53. EP2	Table 53. EP20K30E External Timing Parameters												
Symbol	-1			-2	-3	Unit							
	Min	Max	Min	Max	Min	Max							
t _{INSU}	2.02		2.13		2.24		ns						
t _{INH}	0.00		0.00		0.00		ns						
t _{outco}	2.00	4.88	2.00	5.36	2.00	5.88	ns						
t _{INSUPLL}	2.11		2.23		-		ns						
t _{INHPLL}	0.00		0.00		-		ns						
t _{outcopll}	0.50	2.60	0.50	2.88	-	-	ns						

Table 54. EP20K30	Table 54. EP20K30E External Bidirectional Timing Parameters										
Symbol	-1		-2		-3		Unit				
	Min	Max	Min	Max	Min	Max					
t _{insubidir}	1.85		1.77		1.54		ns				
t _{inhbidir}	0.00		0.00		0.00		ns				
t _{outcobidir}	2.00	4.88	2.00	5.36	2.00	5.88	ns				
t _{XZBIDIR}		7.48		8.46		9.83	ns				
t _{ZXBIDIR}		7.48		8.46		9.83	ns				
t _{insubidirpll}	4.12		4.24		-		ns				
t _{inhbidirpll}	0.00		0.00		-		ns				
t _{outcobidirpll}	0.50	2.60	0.50	2.88	-	-	ns				
t _{xzbidirpll}		5.21		5.99		-	ns				
t _{ZXBIDIRPLL}		5.21		5.99		-	ns				

Table 60. EP20K60	Table 60. EP20K60E External Bidirectional Timing Parameters												
Symbol	-1		-2		-3		Unit						
	Min	Max	Min	Max	Min	Max							
t _{insubidir}	2.77		2.91		3.11		ns						
t _{inhbidir}	0.00		0.00		0.00		ns						
t _{outcobidir}	2.00	4.84	2.00	5.31	2.00	5.81	ns						
t _{xzbidir}		6.47		7.44		8.65	ns						
t _{zxbidir}		6.47		7.44		8.65	ns						
t _{insubidirpll}	3.44		3.24		-		ns						
t _{inhbidirpll}	0.00		0.00		-		ns						
t _{outcobidirpll}	0.50	3.37	0.50	3.69	-	-	ns						
t _{XZBIDIRPLL}		5.00		5.82		-	ns						
t _{ZXBIDIRPLL}		5.00		5.82		-	ns						

Tables 61 through 66 describe f_{MAX} LE Timing Microparameters, f_{MAX} ESB Timing Microparameters, f_{MAX} Routing Delays, Minimum Pulse Width Timing Parameters, External Timing Parameters, and External Bidirectional Timing Parameters for EP20K100E APEX 20KE devices.

Table 61. EP20K100E f _{MAX} LE Timing Microparameters											
Symbol		-1		-2	-	3	Unit				
	Min	Max	Min	Max	Min	Max					
t _{SU}	0.25		0.25		0.25		ns				
t _H	0.25		0.25		0.25		ns				
t _{CO}		0.28		0.28		0.34	ns				
t _{LUT}		0.80		0.95		1.13	ns				

Tables 85 through 90 describe f_{MAX} LE Timing Microparameters, f_{MAX} ESB Timing Microparameters, f_{MAX} Routing Delays, Minimum Pulse Width Timing Parameters, External Timing Parameters, and External Bidirectional Timing Parameters for EP20K400E APEX 20KE devices.

Table 85. EP	Table 85. EP20K400E f _{MAX} LE Timing Microparameters												
Symbol	-1 Spec	ed Grade	-2 Speed Grade		-3 Spee	d Grade	Unit						
	Min	Max	Min	Max	Min	Max							
t _{SU}	0.23		0.23		0.23		ns						
t _H	0.23		0.23		0.23		ns						
t _{CO}		0.25		0.29		0.32	ns						
t _{LUT}		0.70		0.83		1.01	ns						

Table 102. EP20K1	Table 102. EP20K1000E External Bidirectional Timing Parameters											
Symbol	-1 Speed Grade		-2 Spee	d Grade	-3 Spec	Unit						
	Min	Max	Min	Max	Min	Max						
t _{insubidir}	3.22		3.33		3.51		ns					
t _{inhbidir}	0.00		0.00		0.00		ns					
toutcobidir	2.00	5.75	2.00	6.33	2.00	6.90	ns					
t _{XZBIDIR}		6.31		7.09		7.76	ns					
t _{ZXBIDIR}		6.31		7.09		7.76	ns					
t _{INSUBIDIRPL} L	3.25		3.26				ns					
t _{inhbidirpll}	0.00		0.00				ns					
t _{outcobidirpll}	0.50	2.25	0.50	2.99			ns					
t _{XZBIDIRPLL}		2.81		3.80			ns					
t _{ZXBIDIRPLL}		2.81		3.80			ns					

Tables 103 through 108 describe f_{MAX} LE Timing Microparameters, f_{MAX} ESB Timing Microparameters, f_{MAX} Routing Delays, Minimum Pulse Width Timing Parameters, External Timing Parameters, and External Bidirectional Timing Parameters for EP20K1500E APEX 20KE devices.

Table 103. EP20K1500E f _{MAX} LE Timing Microparameters											
Symbol	-1 Spee	d Grade	-2 Speed Grade		-3 Spee	d Grade	Unit				
	Min	Max	Min	Max	Min	Max					
t _{SU}	0.25		0.25		0.25		ns				
t _H	0.25		0.25		0.25		ns				
t _{CO}		0.28		0.32		0.33	ns				
t _{LUT}		0.80		0.95		1.13	ns				

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Table 108. EP20K1	Table 108. EP20K1500E External Bidirectional Timing Parameters											
Symbol	-1 Speed Grade		-2 Speed Grade		-3 Spec	Unit						
	Min	Max	Min	Max	Min	Max						
t _{insubidir}	3.47		3.68		3.99		ns					
t _{inhbidir}	0.00		0.00		0.00		ns					
toutcobidir	2.00	6.18	2.00	6.81	2.00	7.36	ns					
t _{XZBIDIR}		6.91		7.62		8.38	ns					
t _{ZXBIDIR}		6.91		7.62		8.38	ns					
t _{insubidirpll}	3.05		3.26				ns					
t _{inhbidirpll}	0.00		0.00				ns					
t _{outcobidirpll}	0.50	2.67	0.50	2.99			ns					
t _{XZBIDIRPLL}		3.41		3.80			ns					
t _{ZXBIDIRPLL}		3.41		3.80			ns					

Tables 109 and 110 show selectable I/O standard input and output delays for APEX 20KE devices. If you select an I/O standard input or output delay other than LVCMOS, add or subtract the selected speed grade to or from the LVCMOS value.

Table 109. Selectable I/O Standard Input Delays							
Symbol	-1 Speed Grade		-2 Speed Grade		-3 Speed Grade		Unit
	Min	Max	Min	Max	Min	Max	Min
LVCMOS		0.00		0.00		0.00	ns
LVTTL		0.00		0.00		0.00	ns
2.5 V		0.00		0.04		0.05	ns
1.8 V		-0.11		0.03		0.04	ns
PCI		0.01		0.09		0.10	ns
GTL+		-0.24		-0.23		-0.19	ns
SSTL-3 Class I		-0.32		-0.21		-0.47	ns
SSTL-3 Class II		-0.08		0.03		-0.23	ns
SSTL-2 Class I		-0.17		-0.06		-0.32	ns
SSTL-2 Class II		-0.16		-0.05		-0.31	ns
LVDS		-0.12		-0.12		-0.12	ns
CTT		0.00		0.00		0.00	ns
AGP		0.00		0.00		0.00	ns

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